EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L2	4	(parallel near test$4).clm. and chip and (padgroup or pad adj group)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/01/20 11:18
L3	17	parallel near (test$4 or prob$4) and chip and (padgroup or pad adj group)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/01/20 11:25
L4	1	parallel near (test$4 or prob$4) and chip and (padgroup or pad near group) and (inspect$4 near tool or sem or electron near microscop$3)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/01/20 11:39
L5	264	parallel near (test$4 or prob$4) and chip and (inspect$4 near tool or sem or electron near microscop$3)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/01/20 11:40
L6	33	parallel near (test$4 or prob$4) same chip and (inspect$4 near tool or sem or electron near microscop$3)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/01/20 11:41
L7	42	("4573146" | "4769784" | "5110754" | "5212442" | "5241496" | "5257229" | "5291454" | "5291455" | "5297099" | "5307318" | "5355340" | "5381373" | "5467356" | "5473198").PN. OR ("5657284").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2008/01/20 11:58
L8	1	parallel near (test$4 or prob$4) same (padgroup or pad with group$4) and (inspect$4 near tool or sem or electron near microscop$3 or stm)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/01/20 12:09
L9	1	parallel with (test$4 or prob$4) same (padgroup or pad with group$4) and (inspect$4 near tool or sem or electron near microscop$3 or stm)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/01/20 12:09

L10	109	parallel with (test$4 or prob$4) same (pads or padgroup or pad with group$4) and (inspect$4 near tool or sem or electron near microscop$3 or stm)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/01/20 12:10
L11	14	parallel near3 (test$4 or prob$4) same (prob$4 or test$4 or bond$4) near (pads or padgroup or pad with group$4) and (inspect$4 near tool or sem or electron near microscop$3 or stm)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/01/20 12:36
L12	212	parallel near3 (test$4 or prob$4) and (prob$4 or test$4 or bond$4) near (pads or padgroup or pad with group$4) and (inspect$4 near tool or sem or electron near microscop$3 or stm)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/01/20 12:39
L13	165	parallel near (test$4 or prob$4) and (prob$4 or test$4 or bond$4) near (pads or padgroup or pad with group$4) and (inspect$4 near tool or sem or electron near microscop$3 or stm)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/01/20 12:39
L14	1	(parallel near (test$4 or prob$4) and (prob$4 or test$4 or bond$4) near (pads or padgroup or pad with group$4) and (inspect$4 near tool or sem or electron near microscop$3 or stm)).clm.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/01/20 12:40
L15	166	parallel near (test$4 or prob$4) and (prob$4 or test$4 or bond$4) near (pads or padgroup or pad with group$4) and (inspect$4 near tool or sem or scan$4 near microscop$3 or stm)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/01/20 12:41
L16	4	parallel near (test$4 or prob$4) same (prob$4 or test$4 or bond$4) near (pads or padgroup or pad with group$4 or structure) and (inspect$4 near tool or sem or scan$4 near microscop$3 or stm)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/01/20 12:42